


<b>Search Notes</b> 	<b>Application/Control No.</b> 10573630	<b>Applicant(s)/Patent Under Reexamination</b> OHISHI ET AL.
	<b>Examiner</b> Nguyen, Dung V	<b>Art Unit</b> 3723

SEARCHED			
Class	Subclass	Date	Examiner
451	5	3/30/2007	DVN
451	6	3/30/2007	DVN
451	8-11	3/30/2007	DVN
451	59	3/30/2007	DVN
451	75	3/30/2007	DVN
451	92	3/30/2007	DVN

SEARCH NOTES		
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